Small Signal MOSFET

20 V, Dual N-Channel, SC-88 ESD Protection

Features

- Small Footprint (2 x 2 mm)
- Low Gate Charge N-Channel Device
- ESD Protected Gate
- Pb-Free Package for Green Manufacturing (G Suffix)
- Same Package as SC-70 (6 Leads)

Applications

- Load Power switching
- Li-Ion Battery Supplied Devices
- Cell Phones, Media Players, Digital Cameras, PDAs
- DC-DC Conversion

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parame	Symbol	Value	Units				
Drain-to-Source Voltage			V_{DSS}	20	V		
Gate-to-Source Voltage			V_{GS}	±12	V		
		T _A = 25 °C	I _D	0.63	Α		
Current (Based on R _{0JA})	State	T _A = 85 °C		0.46			
Power Dissipation	Steady	T _A = 25 °C	P _D	0.27	W		
(Based on R _{θJA})	State	T _A = 85 °C		0.14			
Continuous Drain	Steady	T _A = 25 °C	I _D	0.91	Α		
Current (Based on R _{0JL})	State	T _A = 85 °C		0.65			
Power Dissipation				0.55	W		
(Based on R _{θJL})	State	T _A = 85 °C	P_{D}	0.29			
Pulsed Drain Current	I _{DM}	±1.2	Α				
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	°C		
Continuous Source Current (Body Diode)			IS	0.63	Α		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C		

THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Тур	Max	Units
Junction-to-Ambient - Steady State	$R_{\theta JA}$	400	460	°C/W
Junction-to-Lead (Drain) - Steady State	$R_{\theta JL}$	194	226	

1. Surface mounted on FR4 board using 1 oz Cu area = 0.9523 in sq.

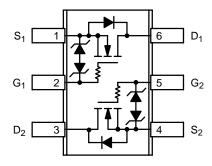


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V _{(BR)DSS}	R _{DS(on)} TYP	I _D Max	
20 V	0.29 Ω @ 4.5 V	0.63 A	
	0.36 Ω @ 2.5 V	0.03 A	

SOT-363 SC-88 (6 LEADS)



Top View

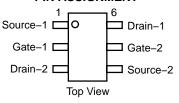


TDD O

MARKING DIAGRAM

TD = Device Code
D = Date Code

PIN ASSIGNMENT



ORDERING INFORMATION

Device	Package	Shipping
NTJD4401NT1	SOT-363	3000 Units/Reel
NTJD4401NT1G	SOT-363 (Pb-Free)	3000 Units/Reel

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS								
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_{D}$	20	27		V		
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				22		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V	_{DS} = 16 V			1.0	μА	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{C}$	_{SS} = ±12 V			10	μА	
ON CHARACTERISTICS (Note 2)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{DS}$	ο = 250 μΑ	0.6	0.92	1.5	V	
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-2.1		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 0.63 \text{ A}$			0.29	0.375	Ω	
		$V_{GS} = 2.5 \text{ V}, I_D = 0.40 \text{ A}$			0.36	0.445		
Forward Transconductance	9 _{FS}	V _{DS} = 4.0 V, I _D = 0.63 A			2.0		S	
CHARGES AND CAPACITANCES								
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 20 \text{ V}$			33	46	pF	
Output Capacitance	C _{OSS}				13	22		
Reverse Transfer Capacitance	C _{RSS}				2.8	5.0		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V	' _{DS} = 10 V,		1.3	3.0	nC	
Threshold Gate Charge	Q _{G(TH)}	$I_{D} = 0.6$	03 A		0.1			
Gate-to-Source Charge	Q _{GS}				0.2			
Gate-to-Drain Charge	Q_{GD}				0.4			
SWITCHING CHARACTERISTICS (No	ote 3)							
Turn-On Delay Time	td _(ON)	V _{GS} = 4.5 V, V	_{DD} = 10 V,		0.083		μs	
Rise Time	tr	$I_D = 0.5 \text{ A}, R_G = 20 \Omega$			0.227			
Turn-Off Delay Time	td _(OFF)				0.786			
Fall Time	tf				0.506			
DRAIN-SOURCE DIODE CHARACTE	RISTICS							
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V},$	T _J = 25°C		0.76	1.1	V	
		I _S =0.23 Å	T _J = 125°C		0.63			
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dI}_{S}/dt$ $I_{S} = 0.6$			0.410		μs	

Pulse Test: pulse width ≤ 300µs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

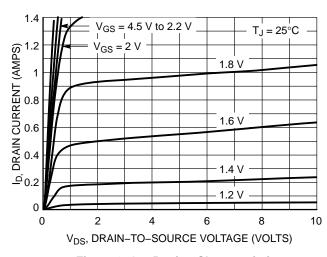


Figure 1. On-Region Characteristics

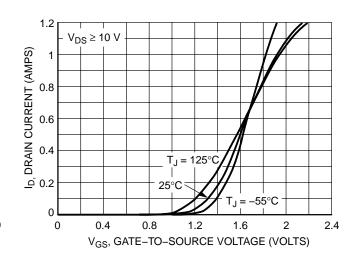


Figure 2. Transfer Characteristics

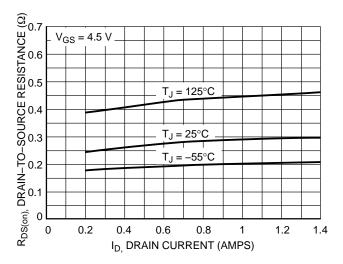


Figure 3. On–Resistance vs. Drain Current and Temperature

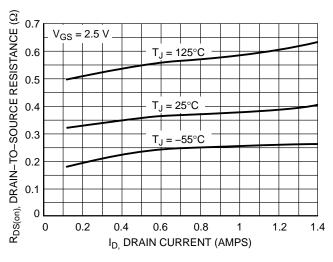


Figure 4. On–Resistance vs. Drain Current and Temperature

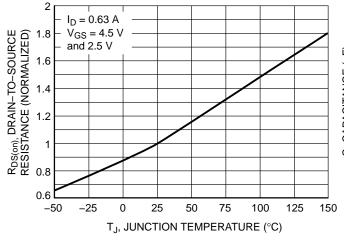


Figure 5. On–Resistance Variation with Temperature

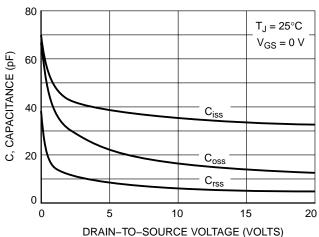


Figure 6. Capacitance Variation

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

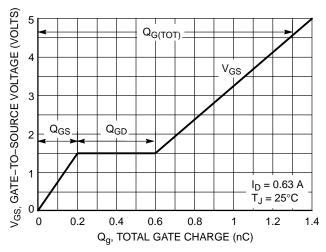


Figure 7. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

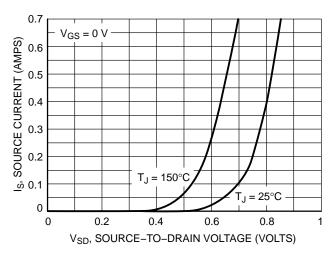
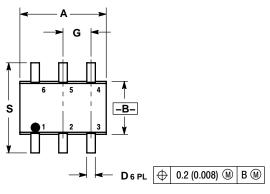
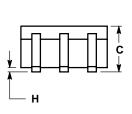


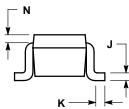
Figure 8. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

SC-88 (SOT-363) CASE 419B-02 ISSUE R







- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. 419B-01 OBSOLETE, NEW STANDARD 419B-02.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.071	0.087	1.80	2.20	
В	0.045	0.053	1.15	1.35	
С	0.031	0.043	0.80	1.10	
D	0.004	0.012	0.10	0.30	
G	0.026	BSC	0.65 BSC		
Н		0.004		0.10	
J	0.004	0.010	0.10	0.25	
K	0.004	0.012	0.10	0.30	
N	0.008	REF	0.20 REF		
S	0.079	0.087	2.00	2.20	

- STYLE 26: PIN 1. SOURCE 1 2. GATE 1 3. DRAIN 2 4. SOURCE 2 5. GATE 2 6. DRAIN 1

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